

Application No. 09/832,642  
Amendment dated June 20, 2003  
Reply to Office action of March 20, 2003

This listing of claims will replace all prior versions, and listings, of claims in the application:

**Listing of Claims:**

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1           Claim 1 (Original): An electrical test probe tip, comprising:  
2           (a)     a conductive flexible coil having a first end and a second end;  
3           (b)     said first end for coupling with a device to be probed; and  
4           (c)     a connector attached to said second end of said conductive flexible  
5           coil.

*Bl* 1           Claim 2 (Original): The electrical test probe tip of claim 1, said connector  
2           being a connecting pin coupleable to a probing head.

1           Claim 3 (Original): The electrical test probe tip of claim 1, said connector  
2           being a square pin coupleable to a probing head.

1           Claim 4 (Withdrawn):

1           Claim 5 (Original): The electrical test probe tip of claim 1, said flexible coil  
2           having a longitudinal axis and a first diameter, said first diameter being substantially  
3           equal throughout said longitudinal axis of said flexible coil.

1           Claim 6-12 (Withdrawn):

1           Claim 13 (Original): A multipurpose electrical test probe tip, comprising:  
2           (a)     a conductive flexible member;  
3           (b)     said flexible member having a first end and a second end;

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- 4                   (c)     said flexible member being substantially hollow at said first end;  
5                   and  
6                   (d)     said first end of said conductive flexible member for flexibly  
7                   coupling with a component to be probed.

1                   Claim 14 (Original): The multipurpose electrical test probe tip of claim 13,  
2                   wherein said second end of said conductive flexible member is interconnectable with a  
3                   probing head.

1                   Claim 15 (Withdrawn):

1                   Claim 16 (Original): The multipurpose electrical test probe tip of claim 14,  
2                   said second end of said conductive flexible member further comprising a connector  
3                   coupleable with said probing head.

1                   Claim 17 (Original): The multipurpose electrical test probe tip of claim 13,  
2                   said flexible member having a longitudinal axis and a first diameter, said first diameter  
3                   being substantially equal throughout said longitudinal axis of said flexible coil.

1                   Claim 18-27 (Withdrawn):

1                   Claim 28 (New): The electrical test probe tip of claim 1, said conductive  
2                   flexible coil being substantially hollow at said first end.

1                   Claim 29 (New): The electrical test probe tip of claim 1, said conductive  
2                   flexible coil being substantially hollow.

1                   Claim 30 (New): The electrical test probe tip of claim 1, said first end of  
2                   said conductive flexible coil being suitable to receive a device to be probed therein.

1                   Claim 31 (New): The electrical test probe tip of claim 1, wherein said first  
2                   end of said conductive flexible coil at least partially surrounds a device to be probe!

1                   Claim 32 (New): The multipurpose electrical test probe tip of claim 13,  
2                   said conductive flexible member being substantially hollow.

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1           Claim 33 (New): The multipurpose electrical test probe tip of claim 13,  
2    said first end of said conductive flexible member being suitable to receive a component  
3    to be probed therein.

1           Claim 34 (New): The multipurpose electrical test probe tip of claim 13,  
2    wherein said first end of said conductive flexible member at least partially surrounds a  
3    component to be probed.